

MOSFET - Power, Dual **N-Channel** 40 V, 14.5 mΩ, 29 A NVMJD015N04CL

Features

- Small Footprint (5 x 6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	40	V
Gate-to-Source Voltage	€		V _{GS}	±20	V
Continuous Drain	Steady	T _C = 25°C	I _D	29	Α
Current R _{0JC} (Notes 1, 2, 3, 4)		T _C = 100°C		20.7	
Power Dissipation	State	T _C = 25°C	P_{D}	23	W
R _{θJC} (Notes 1, 2, 3)		T _C = 100°C		12	
Continuous Drain		T _A = 25°C	I _D	10.6	Α
Current R _{θJA} (Notes 1, 3, 4)	Steady	T _A = 100°C		7.5	
Power Dissipation	State	T _A = 25°C	P_{D}	3.1	W
R _{θJA} (Notes 1, 3)		T _A = 100°C		1.5	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	180	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	19	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 1.4 A)			E _{AS}	48	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

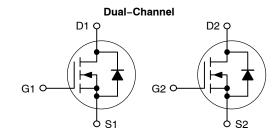
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	6.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	48.8	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
40 V	14.5 mΩ @ 10 V	29 A	
40 V	25 mΩ @ 4.5 V	29 A	





WL = Wafer Lot = Year Υ = Work Week

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-				-		-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				27.2		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			10	μΑ
		$V_{GS} = 0 V$, $V_{DS} = 40 V$	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 20 μA	1.2		2.2	V
Negative Threshold Temperature Coefficient	V _{(BR)DSS} /T _J				-6.26		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	= 7.5 A		12.2	14.5	mΩ
		V _{GS} = 4.5 V, I _[₎ = 7.5 A		20	25	
Forward Transconductance	9FS	$V_{DS} = 5 \text{ V}, I_{D}$	= 7.5 A		23		S
CHARGES AND CAPACITANCES	•				•		•
Input Capacitance	C _{iss}				432		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, } f = 1.0 \text{ MHz,} $ $V_{DS} = 25 \text{ V}$			169		1
Reverse Transfer Capacitance	C _{rss}				8.5		
Total Gate Charge	Q _{G(TOT)}				7.5		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 32 V, I _D = 15 A			0.8		nC
Gate-to-Source Charge	Q _{GS}				1.4		
Gate-to-Drain Charge	Q_{GD}				1.42		
SWITCHING CHARACTERISTICS (No	te 6)		•				
Turn-On Delay Time	t _{d(on)}				5.7		ns
Rise Time	t _r	V _{GS} = 10 V, V _D	s = 32 V.		1.6		
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 \text{ A}, R_G = 1 \Omega$			12.4		
Fall Time	t _f				1.7		
DRAIN-SOURCE DIODE CHARACTEI	RISTICS				•		
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V},$ $I_{S} = 7.5 \text{ A}$	T _J = 25°C		0.85	1.2	V
			T _J = 125°C		0.72		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dl_S/dt = 100 \text{ A}/\mu\text{s,}$ $l_S = 15 \text{ A}$			16		ns
Charge Time	t _a				9		
Discharge Time	t _b				8		
Reverse Recovery Charge	Q _{RR}				4		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

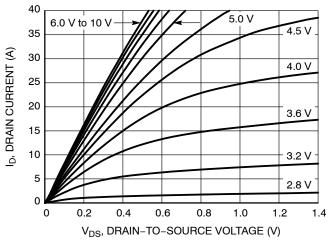


Figure 1. On-Region Characteristics

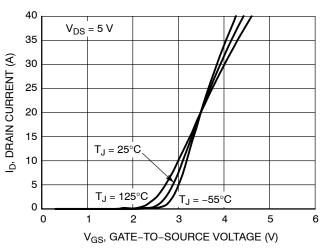


Figure 2. Transfer Characteristics

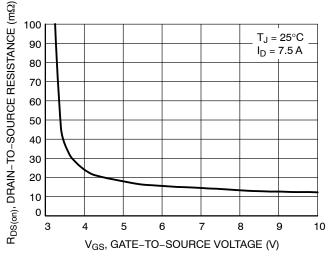


Figure 3. On-Resistance vs. Gate-to-Source Voltage

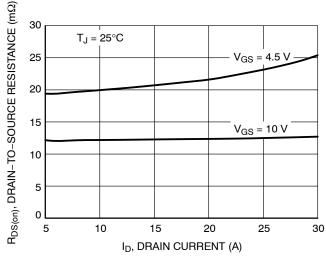


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

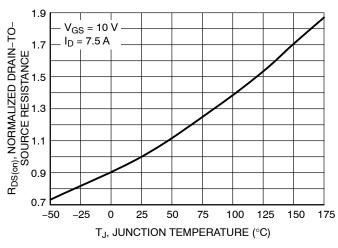


Figure 5. On–Resistance Variation with Temperature

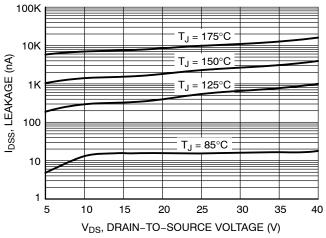
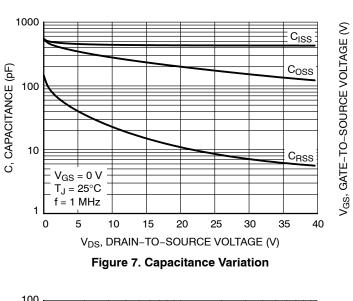


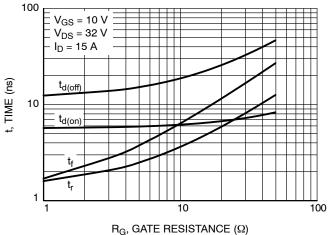
Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS



10 9 8 7 6 5 Q_{GS} Q_{GD} 4 3 V_{DS} = 32 V 2 I_D = 15 A T_J = 25°C 0 2 5 0 6 Q_G, TOTAL GATE CHARGE (nC)

Figure 8. Gate-to-Source Voltage vs. Total Charge



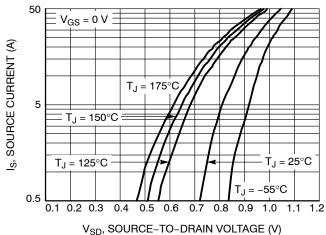
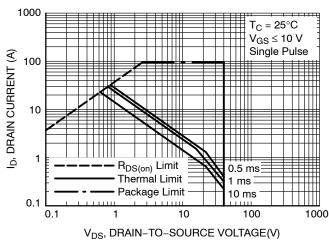


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



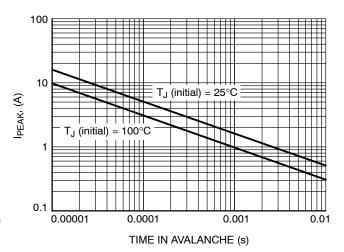


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

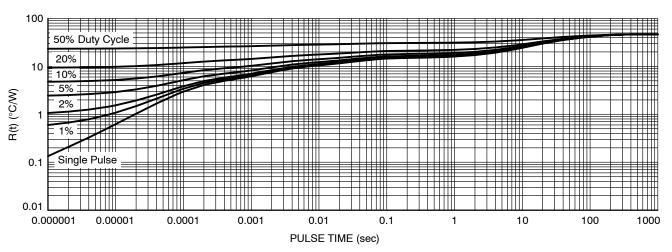


Figure 13. Thermal Characteristics

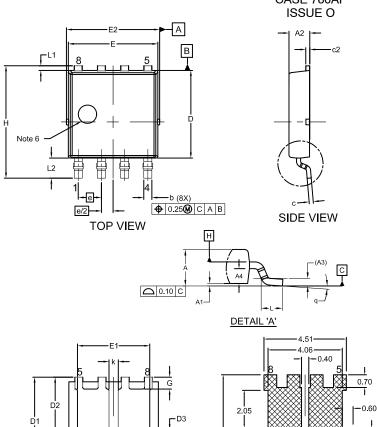
DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMJD015N04CLTWG	015N04CL	LFPAK8 Dual (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

LFPAK8 5.15x6.15 CASE 760AF



6.42

0.70

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M. 1994.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- OPTIONAL MOLD FEATURE.

MILLIMETERS				
DIM	MIN	NOM	MAX	
Α	1.10	1.20	1.30	
A1	0.00	0.08	0.15	
A2	1.10	1.15	1.20	
A3	().25 REF	=	
A4	0.45	0.50	0.55	
b	0.40	0.45	0.50	
С	0.19	0.22	0.25	
c2	0.19	0.22	0.25	
О	4.70	4.80	4.90	
D1	3.80	4.00	4.20	
D2	3.00	3.10	3.20	
D3	0.30	0.40	0.50	
Е	4.80	4.90	5.00	
E1	3.90	4.00	4.10	
E2	5.00	5.15	5.30	
е	1	1.270 BS	C	
e/2	(0.635 BSC		
G	0.55	0.65	0.75	
I	6.00	6.15	6.30	
k	0.40	0.50	0.60	
L	0.45	0.65	0.85	
L1	0.15	0.25	0.35	
L2	0.90	1.10	1.30	
q	0°	4°	8°	

RECOMMENDED LAND PAD

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

0.60

1.06

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